

MM54HC175/MM74HC175 Quad D-Type Flip-Flop With Clear

General Description

This high speed D-TYPE FLIP-FLOP with complementary outputs utilizes advanced silicon-gate CMOS technology to achieve the high noise immunity and low power consumption of standard CMOS integrated circuits, along with the ability to drive 10 LS-TTL loads.

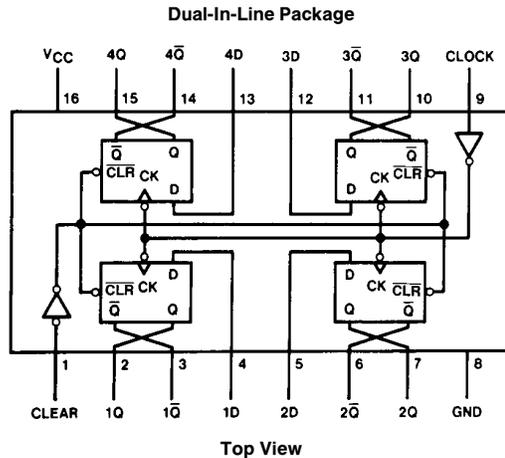
Information at the D inputs of the MM54HC175/MM74HC175 is transferred to the Q and \bar{Q} outputs on the positive going edge of the clock pulse. Both true and complement outputs from each flip flop are externally available. All four flip flops are controlled by a common clock and a common CLEAR. Clearing is accomplished by a negative pulse at the CLEAR input. All four Q outputs are cleared to a logical "0" and all four \bar{Q} outputs to a logical "1."

The 54HC/74HC logic family is functionally as well as pin-out compatible with the standard 54LS/74LS logic family. All inputs are protected from damage due to static discharge by internal diode clamps to V_{CC} and ground.

Features

- Typical propagation delay: 15 ns
- Wide operating supply voltage range: 2–6V
- Low input current: 1 μ A maximum
- Low quiescent supply current: 80 μ A maximum (74HC)
- High output drive current: 4 mA minimum (74HC)

Connection Diagram



TL/F/5319-1

Order Number MM54HC175 or MM74HC175

Truth Table (Each Flip-Flop)

Inputs			Outputs	
Clear	Clock	D	Q	\bar{Q}
L	X	X	L	H
H	\uparrow	H	H	L
H	\uparrow	L	L	H
H	L	X	Q_0	\bar{Q}_0

H = high level (steady state)
 L = low level (steady state)
 X = irrelevant
 \uparrow = transition from low to high level
 Q_0 = the level of Q before the indicated steady-state input conditions were established

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Absolute Maximum Ratings (Notes 1 & 2)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V_{CC})	-0.5 to +7.0V
DC Input Voltage (V_{IN})	-1.5 to $V_{CC} + 1.5V$
DC Output Voltage (V_{OUT})	-0.5 to $V_{CC} + 0.5V$
Clamp Diode Current (I_{IK}, I_{OK})	± 20 mA
DC Output Current, per pin (I_{OUT})	± 25 mA
DC V_{CC} or GND Current, per pin (I_{CC})	± 50 mA
Storage Temperature Range (T_{STG})	-65°C to +150°C
Power Dissipation (P_D) (Note 3)	600 mW
S.O. Package only	500 mW
Lead Temperature (T_L) (Soldering 10 seconds)	260°C

Operating Conditions

	Min	Max	Units
Supply Voltage (V_{CC})	2	6	V
DC Input or Output Voltage (V_{IN}, V_{OUT})	0	V_{CC}	V
Operating Temp. Range (T_A)			
MM74HC	-40	+85	°C
MM54HC	-55	+125	°C
Input Rise or Fall Times (t_r, t_f)			
$V_{CC} = 2.0V$		1000	ns
$V_{CC} = 4.5V$		500	ns
$V_{CC} = 6.0V$		400	ns

DC Electrical Characteristics (Note 4)

Symbol	Parameter	Conditions	V_{CC}	$T_A = 25^\circ C$			Units	
				Typ	74HC $T_A = -40$ to $85^\circ C$	54HC $T_A = -55$ to $125^\circ C$		
V_{IH}	Minimum High Level Input Voltage		2.0V		1.5	1.5	V	
			4.5V		3.15	3.15	V	
			6.0V		4.2	4.2	V	
V_{IL}	Maximum Low Level Input Voltage**		2.0V		0.5	0.5	V	
			4.5V		1.35	1.35	V	
			6.0V		1.8	1.8	V	
V_{OH}	Minimum High Level Output Voltage	$V_{IN} = V_{IH}$ or V_{IL} $ I_{OUT} \leq 20 \mu A$	2.0V	2.0	1.9	1.9	V	
			4.5V	4.5	4.4	4.4	V	
			6.0V	6.0	5.9	5.9	V	
		$V_{IN} = V_{IH}$ or V_{IL} $ I_{OUT} \leq 4.0$ mA $ I_{OUT} \leq 5.2$ mA	4.5V	4.2	3.98	3.84	3.7	V
			6.0V	5.7	5.48	5.34	5.2	V
V_{OL}	Maximum Low Level Output Voltage	$V_{IN} = V_{IH}$ or V_{IL} $ I_{OUT} \leq 20 \mu A$	2.0V	0	0.1	0.1	V	
			4.5V	0	0.1	0.1	V	
			6.0V	0	0.1	0.1	V	
		$V_{IN} = V_{IH}$ or V_{IL} $ I_{OUT} \leq 4.0$ mA $ I_{OUT} \leq 5.2$ mA	4.5V	0.2	0.26	0.33	0.4	V
			6.0V	0.2	0.26	0.33	0.4	V
I_{IN}	Maximum Input Current	$V_{IN} = V_{CC}$ or GND	6.0V		± 0.1	± 1.0	μA	
I_{CC}	Maximum Quiescent Supply Current	$V_{IN} = V_{CC}$ or GND $I_{OUT} = 0 \mu A$	6.0V		8	80	160	μA

Note 1: Absolute Maximum Ratings are those values beyond which damage to the device may occur.

Note 2: Unless otherwise specified all voltages are referenced to ground.

Note 3: Power Dissipation temperature derating — plastic "N" package: -12 mW/°C from 65°C to 85°C; ceramic "J" package: -12 mW/°C from 100°C to 125°C.

Note 4: For a power supply of $5V \pm 10\%$ the worst case output voltages (V_{OH} , and V_{OL}) occur for HC at 4.5V. Thus the 4.5V values should be used when designing with this supply. Worst case V_{IH} and V_{IL} occur at $V_{CC} = 5.5V$ and 4.5V respectively. (The V_{IH} value at 5.5V is 3.85V.) The worst case leakage current (I_{IN} , I_{CC} , and I_{OZ}) occur for CMOS at the higher voltage and so the 6.0V values should be used.

** V_{IL} limits are currently tested at 20% of V_{CC} . The above V_{IL} specification (30% of V_{CC}) will be implemented no later than Q1, CY'89.

AC Electrical Characteristics $V_{CC}=5V, T_A=25^{\circ}C, C_L=15\text{ pF}, t_r=t_f=6\text{ ns}$

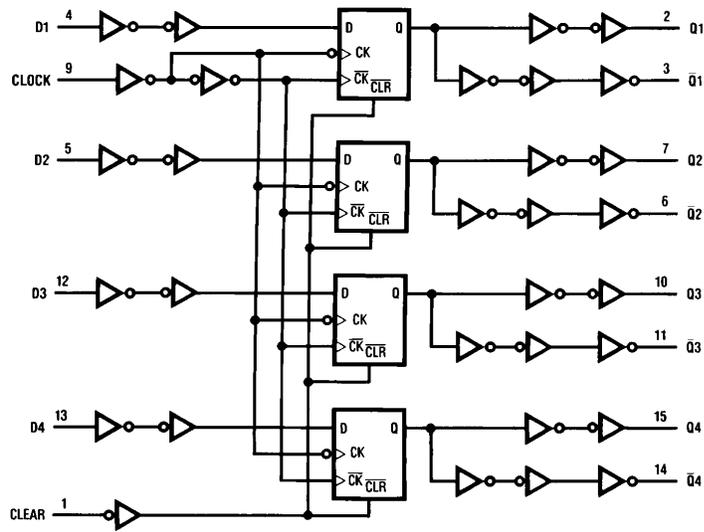
Symbol	Parameter	Conditions	Typ	Guaranteed Limit	Units
f_{MAX}	Maximum Operating Frequency		60	35	MHz
t_{PHL}, t_{PLH}	Maximum Propagation Delay, Clock to Q or \bar{Q}		15	25	ns
t_{PHL}, t_{PLH}	Maximum Propagation Delay, Reset to Q or \bar{Q}		13	21	ns
t_{REC}	Minimum Removal Time, Clear to Clock			20	ns
t_S	Minimum Setup Time, Data to Clock			20	ns
t_H	Minimum Hold Time, Data from Clock			0	ns
t_W	Minimum Pulse Width, Clock or Clear		10	16	ns

AC Electrical Characteristics $V_{CC}=2.0V\text{ to }6.0V, C_L=50\text{ pF}, t_r=t_f=6\text{ ns}$ (unless otherwise specified)

Symbol	Parameter	Conditions	V_{CC}	$T_A=25^{\circ}C$		74HC $T_A=-40\text{ to }85^{\circ}C$		54HC $T_A=-55\text{ to }125^{\circ}C$		Units
				Typ	Guaranteed Limits	Guaranteed Limits	Guaranteed Limits			
f_{MAX}	Maximum Operating Frequency		2.0V	12	6	5	4	MHz		
			4.5V	60	30	24	20	MHz		
			6.0V	70	35	28	24	MHz		
t_{PHL}, t_{PLH}	Maximum Propagation Delay, Clock to Q or \bar{Q}		2.0V	80	150	190	225	ns		
			4.5V	15	30	38	45	ns		
			6.0V	13	26	32	38	ns		
t_{PHL}, t_{PLH}	Maximum Propagation Delay, Reset to Q or \bar{Q}		2.0V	64	125	158	186	ns		
			4.5V	14	25	32	37	ns		
			6.0V	12	21	27	32	ns		
t_{REM}	Minimum Removal Time Clear to Clock		2.0V		100	125	150	ns		
			4.5V		20	25	30	ns		
			6.0V		17	21	25	ns		
t_S	Minimum Setup Time Data to Clock		2.0V		100	125	150	ns		
			4.5V		20	25	30	ns		
			6.0V		17	21	25	ns		
t_H	Minimum Hold Time Data from Clock		2.0V		0	0	0	ns		
			4.5V		0	0	0	ns		
			6.0V		0	0	0	ns		
t_W	Minimum Pulse Width Clear or Clock		2.0V	30	80	100	120	ns		
			4.5V	9	16	20	24	ns		
			6.0V	8	14	17	20	ns		
t_r, t_f	Maximum Input Rise and Fall Time		2.0V		1000	1000	1000	ns		
			4.5V		500	500	500	ns		
			6.0V		400	400	400	ns		
t_{TLH}, t_{THL}	Maximum Output Rise and Fall Time		2.0V	30	75	95	110	ns		
			4.5V	9	15	19	22	ns		
			6.0V	8	13	16	19	ns		
C_{PD}	Power Dissipation Capacitance (Note 5)	(per package)		150				pF		
C_{IN}	Maximum Input Capacitance			5	10	10	10	pF		

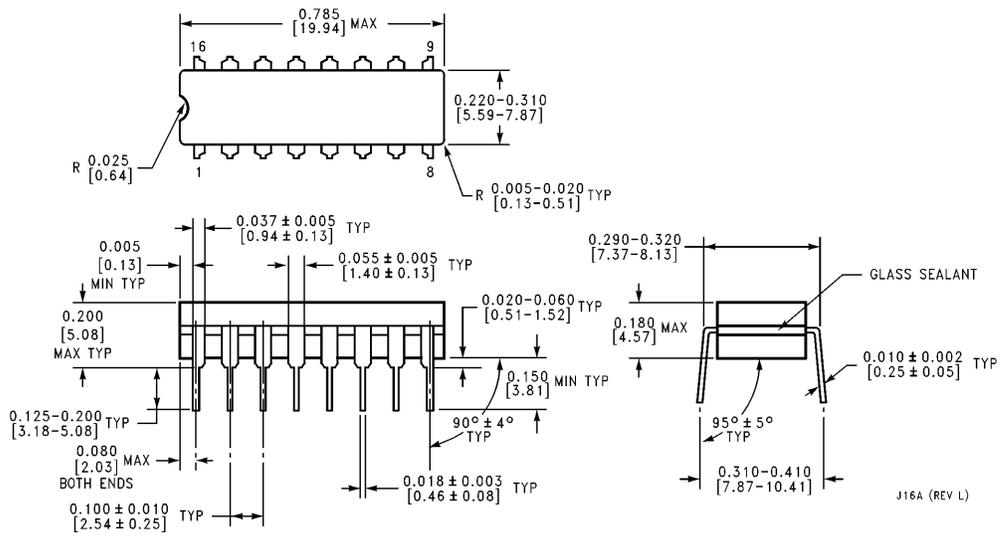
Note 5: C_{PD} determines the no load dynamic power consumption, $P_D = C_{PD} V_{CC}^2 f + I_{CC} V_{CC}$, and the no load dynamic current consumption, $I_S = C_{PD} V_{CC} f + I_{CC}$.

Logic Diagram



TL/F/5319-2

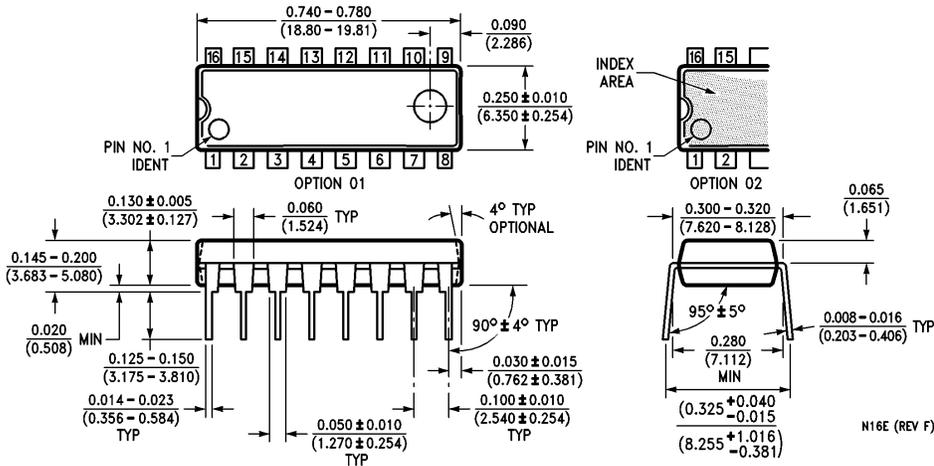
Physical Dimensions inches (millimeters)



Dual-In-Line Package
Order Number MM54HC175J or MM74HC175J
NS Package J16A

J16A (REV L)

Physical Dimensions inches (millimeters) (Continued)



Dual-In-Line Package
Order Number MM74HC175N
NS Package N16E

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